Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10813020	CHANG, YEN SHENG
Examiner	Art Unit
Bonura, Tim	2114

SEARCHED					
Class		Subclass	Date	Examiner	
714	51, 55		1/6/2007	Tim Bonura	
713	500	,	1/6/2007	Tim Bonura	

SEARCH NOTES				
Search Notes	Date	Examiner		
Searched in East using: USPat, USPub, Derwent, EPO, JPO, IBM	1/6/2007	Tim Bonura		
Inventor Name Search	1/6/2007	Tim Bonura		
Consulted with Bryce Bonzo over class searching and NPL	1/6/2007	Tim Bonura		
NPL search	1/6/2007	Tim Bonura		
Search updated	5/24/2007	Tim Bonura		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
	Searched in East using claim text	5/24/2007	Tim Bonura			

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